Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/695,508	SMITH ET AL.	
Examiner	Art Unit	
Shih-wen Hsieh	2861	

SEARCHED				
Class	Subclass	Date	Examiner	
347	updated	1/18/2006	SWH	
323	282,351	1/18/2006	swh	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
cinsulted with primary Adolf Berhane, au 2838	1/18/2006	swh
east text search (see attached)	1/18/2006	swh
USPGPUB text search (see attached)	1/18/2006	swн